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SBOS538F - JANUARY 2011 - REVISED DECEMBER 2016

# OPAx322x 20-MHz, Low-Noise, 1.8-V, RRI/O, **CMOS Operational Amplifier With Shutdown**

Technical

Documents

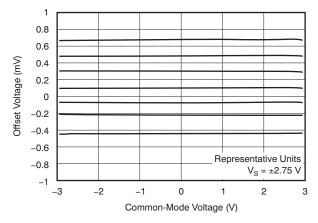
#### Features 1

- Gain Bandwidth: 20 MHz
- Low Noise: 8.5 nV $\sqrt{Hz}$  at 1 kHz
- Slew Rate: 10 V/µs
- Low THD+N: 0.0005%
- Rail-to-Rail I/O
- Offset Voltage: 2 mV (maximum)
- Supply Voltage: 1.8 V to 5.5 V
- Supply Current: 1.5 mA/ch
- Shutdown: 0.1 μA/ch
- Unity-Gain Stable
- Small Packages:
  - SOT-23, SON, VSSOP, TSSOP

# 2 Applications

- Sensor Signal Conditioning
- **Consumer Audio**
- Multi-Pole Active Filters
- **Control-Loop Amplifiers**
- Communications
- Security
- Scanners

#### Zero-Crossover Rail-to-Rail Input Stage Eliminates Distortion



## 3 Description

Tools &

Software

The OPAx322x series consists of single, dual, and quad-channel CMOS operational amplifiers featuring low noise and rail-to-rail inputs and outputs optimized for low-power, single-supply applications. Specified over a wide supply range of 1.8 V to 5.5 V, the low quiescent current of only 1.5 mA per channel makes well-suited for power-sensitive these devices applications.

Support &

2.2

The combination of very low noise (8.5 nV $\sqrt{Hz}$  at 1 kHz), high-gain bandwidth (20 MHz), and fast slew rate (10 V/µs) make the OPAx322x family ideal for a wide range of applications, including signal conditioning and sensor amplification requiring high gains. Featuring low THD+N, the OPAx322x series is also excellent for consumer audio applications, particularly for single-supply systems.

The OPAx322S models include a shutdown mode that allow the amplifiers to be switched from normal operation to a standby current that is typically less than 0.1  $\mu$ A.

The OPA322 (single version) is available in 5-pin SOT-23 and 6-pin SOT-23, while the OPA2322 (dual version) is offered in 8-pin VSSOP, 10-pin VSSOP, 8pin SOIC, and 8-pin SON packages. The quad version OPA4322 comes in 14-pin TSSOP and 16-pin TSSOP packages. All versions are specified for operation from -40°C to +125°C.

PART NUMBER	PACKAGE	BODY SIZE (NOM)						
OPA322	SOT-23 (5)	2.90 mm × 1.60 mm						
OPA322S	SOT-23 (6)	2.90 mm × 1.60 mm						
	SOIC (8)	4.90 mm × 3.91 mm						
OPA2322	VSSOP (8)	3.00 mm × 3.00 mm						
	SON (8)	3.00 mm × 3.00 mm						
OPA2322S	VSSOP (10)	3.00 mm × 3.00 mm						
OPA4322	TSSOP (14)	5.00 mm × 4.40 mm						
OPA4322S	TSSOP (16)	5.00 mm × 4.40 mm						

## Device Information<sup>(1)</sup>

(1) For all available packages, see the orderable addendum at the end of the data sheet.



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## **4** Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

	hanges from Revision E (June 2012) to Revision F	Page
•	Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section	1
•	Changed device package descriptions to current standards	1
•	Deleted Package/Ordering Information table; see Package Option Addendum at the end of this data sheet	7
CI	hanges from Revision D (March 2012) to Revision E	Page
CI •	hanges from Revision D (March 2012) to Revision E Changed product status from Production Data to Mixed Status	
CI •	• • •	1
CI • •	Changed product status from Production Data to Mixed Status	1 5 15

#### Changes from Revision C (November 2011) to Revision D

•	Changed product status from Mixed Status to Production Data	. 1
•	Added OPA4322, OPA4322S to the Input Bias Current, Input bias current, Over temperature parameter in Electrical	
	Characteristics table	. 9
•	Changed Power Supply, OPA4322, OPA4322S <i>Over temperature</i> parameter maximum specification in the Electrical Characteristics table	10

Changes from Revision B (July 2011) to Revision C					
•	Changed status of OPA2322 SO-8 (D) to production data from product preview	1			

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#### Changes from Revision A (May 2011) to Revision B

#### Page

•	Added OPA322S thermal information to OPA322 Thermal Information table	. 8
•	Added OPA2322S thermal information to OPA2322 Thermal Information table	. 8
•	Added OPA4322S thermal information to OPA4322 Thermal Information table	. 8
•	Changed Input Bias Current Input bias current, Over temperature parameter in Electrical Characteristics table	. 9
•	Changed Open-Loop Gain, Open-loop voltage gain parameter typical specification in the Electrical Characteristics table	. 9
•	Changed Open-Loop Gain, Phase margin parameter test conditions in the Electrical Characteristics table	. 9
•	Changed Power Supply, Quiescent current per amplifier OPA322/S parameter maximum specification in the Electrical Characteristics	10
•	Changed Power Supply, OPA322 Over temperature parameter maximum specification in the Electrical Characteristics table	10
•	Changed Power Supply, Quiescent current per amplifier OPA4322/S parameter typical specification in the Electrical Characteristics	10
•	Added test conditions to Power Supply section in Electrical Characteristics table	10
•	Changed Shutdown, Quiescent current, per amplifier parameter maximum specification in Electrical Characteristics table	10
•	Updated Figure 1	11
•	Added Figure 25	
•	Changed Overload Recovery Time section	

### Changes from Original (January 2011) to Revision A

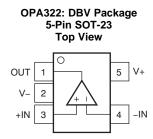
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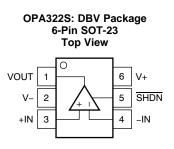
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Changed document status to Production Date	۲۲



# 5 Pin Configuration and Functions

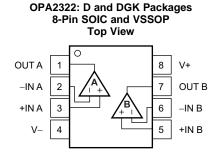


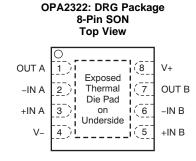


## Pin Functions: OPA322, OPA322S

	PIN			
	OPA322	DPA322 OPA322S I/O DESCRIPTION	DESCRIPTION	
NAME	SOT-23	SOT-23	Ī	
-IN	4	4	I	Inverting input
+IN	3	3	I	Noninverting input
OUT	1	1	0	Output
SHDN	—	5	I	Shutdown control (active low)
V–	2	2	—	Negative (lowest) power supply
V+	5	6	_	Positive (highest) power supply

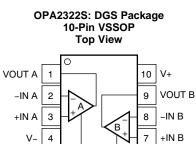






(1) Connect thermal pad to V-.

(2) Pad size: 2 mm x 1.2 mm.



#### Pin Functions: OPA2322, OPA2322S

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SHDN B

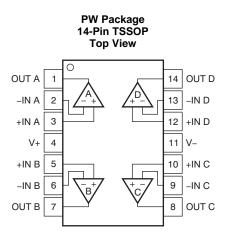
SHDN A

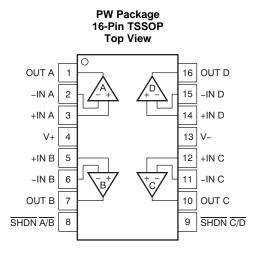
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PIN						
	OPA2322		OPA2322S	I/O	DESCRIPTION	
NAME	SOIC, VSSOP	SON	VSSOP			
–IN A	2	2	2	Ι	Inverting input, channel A	
+IN A	3	3	3	Ι	Noninverting input, channel A	
–IN B	6	6	8	Ι	Inverting input, channel B	
+IN B	5	5	7	I	Noninverting input, channel B	
OUT A	1	1	—	0	Output, channel A	
OUT B	7	7	—	0	Output, channel B	
SHDN A	_		5	Ι	Shutdown control, channel A (active low)	
SHDN B	_		6	Ι	Shutdown control, channel B (active low)	
V–	4	4	4	_	Negative (lowest) power supply	
V+	8	8	10	_	Positive (highest) power supply	
VOUT A	_	—	1	0	Output, channel A	
VOUT B	—	—	9	0	Output, channel B	

Product Folder Links: OPA322 OPA322S OPA2322 OPA2322S OPA4322 OPA4322S







### Pin Functions: OPA4322, OPA4322S

PIN					
NAME	OPA4322	OPA4322S	I/O	DESCRIPTION	
NAWE	TSSOP	TSSOP			
–IN A	2	2	Ι	Inverting input, channel A	
+IN A	3	3	Ι	Noninverting input, channel A	
–IN B	6	6	Ι	Inverting input, channel B	
+IN B	5	5	Ι	Noninverting input, channel B	
–IN C	9	11	I	Inverting input, channel C	
+IN C	10	12	Ι	Noninverting input, channel C	
–IN D	13	15	Ι	Inverting input, channel D	
+IN D	12	14	Ι	Noninverting input, channel D	
OUT A	1	1	0	Output, channel A	
OUT B	7	7	0	Output, channel B	
OUT C	8	10	0	Output, channel C	
OUT D	14	16	0	Output, channel D	
SHDN A/B	_	8	Ι	Shutdown control, channels A and B (active low)	
SHDN C/D		9	Ι	Shutdown control, channels C and D (active low)	
V–	11	13	—	Negative (lowest) power supply	
V+	4	4		Positive (highest) power supply	

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Product Folder Links: OPA322 OPA322S OPA2322 OPA2322S OPA4322 OPA4322S



## 6 Specifications

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
	Supply voltage, $V_S = (V+) - (V-)$		6	V
Voltage	Signal input pins <sup>(2)</sup>	(V–) – 0.5	(V+) + 0.5	V
Current	Signal input pins <sup>(2)</sup>	-10	10	mA
Current	Output short-circuit <sup>(3)</sup>	Conti	nuous	
	Operating, T <sub>A</sub>	-40	150	°C
Temperature	Junction, T <sub>J</sub>		150	°C
	Storage, T <sub>stg</sub>	-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5 V beyond the supply rails must be current limited to 10 mA or less.

(3) Short-circuit to ground, one amplifier per package.

## 6.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±4000	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1000	V
		Machine model (MM)	±200	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
Vs	Specified voltage	1.8	5.5	V
T <sub>A</sub>	Specified temperature	-40	125	°C

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## 6.4 Thermal Information: OPA322, OPA322S

		OPA322	OPA322S	
	THERMAL METRIC <sup>(1)</sup>	DBV (SOT-23)	DBV (SOT-23)	UNITS
		5 PINS	6 PINS	
$R_{ hetaJA}$	Junction-to-ambient thermal resistance	219.3	177.5	°C/W
$R_{\theta JC(top)}$	Junction-to-case(top) thermal resistance	107.5	108.9	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	57.5	27.4	°C/W
ΨJT	Junction-to-top characterization parameter	7.4	13.3	°C/W
Ψјв	Junction-to-board characterization parameter	56.9	26.9	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case(bottom) thermal resistance	_	_	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

## 6.5 Thermal Information: OPA2322, OPA2322S

			OPA2322		OPA2322S	
	THERMAL METRIC <sup>(1)</sup>	D (SOIC)	DRG (SON)	DGK (VSSOP)	DGS (VSSOP)	
		8 PINS	8 PINS	8 PINS	10 PINS	UNITS
$R_{\theta JA}$	Junction-to-ambient thermal resistance	122.6	50.6	174.8	171.5	°C/W
$R_{\theta JC(top)}$	Junction-to-case(top) thermal resistance	67.1	54.9	43.9	43	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	64	25.2	95	91.4	°C/W
ΨJT	Junction-to-top characterization parameter	13.2	0.6	2	1.9	°C/W
Ψјв	Junction-to-board characterization parameter	63.4	25.3	93.5	89.9	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case(bottom) thermal resistance	_	5.7	_	_	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

### 6.6 Thermal Information: OPA4322, OPA4322S

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		OPA4322	OPA4322S	
	THERMAL METRIC <sup>(1)</sup>	PW (TSSOP)	PW (TSSOP)	
		14 PINS	16 PINS	UNITS
$R_{\theta JA}$	Junction-to-ambient thermal resistance	109.8	105.9	°C/W
$R_{\theta JC(top)}$	Junction-to-case(top) thermal resistance	34.9	28.1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	52.5	51.1	°C/W
ΨJT	Junction-to-top characterization parameter	2.2	0.8	°C/W
ΨJB	Junction-to-board characterization parameter	51.8	50.4	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case(bottom) thermal resistance	—	—	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



#### 6.7 Electrical Characteristics

At  $V_S = 1.8$  V to 5.5 V, or ±0.9 V to ±2.75 V,  $T_A = 25^{\circ}$ C,  $R_L = 10$  k $\Omega$  connected to  $V_S/2$ ,  $V_{CM} = V_S/2$ ,  $V_{OUT} = V_S/2$ , and SHDN\_x =  $V_S$ + (unless otherwise noted).

	PARAMETER	TEST CONDIT	IONS	MIN	TYP	MAX	UNIT
OFFSET	VOLTAGE						
V <sub>OS</sub>	Input offset voltage				0.5	2	mV
dV <sub>OS</sub> /dT	vs temperature	V <sub>S</sub> = 5.5 V	-		1.8	6	μV/°C
PSR		$\mathcal{N} = 1.8 \mathcal{N}$ to 5.5 $\mathcal{N}$	$T_A = 25^{\circ}C$		10	50	μV/V
FOR	vs power supply	$V_{\rm S}$ = 1.8 V to 5.5 V	$T_A = -40^{\circ}C$ to $125^{\circ}C$		20	65	μν/ν
	Channel separation	At 1 kHz			130		dB
INPUT V	OLTAGE						
V <sub>CM</sub>	Common-mode voltage range			(V–) – 0.1		(V+) + 0.1	V
01400	Common-mode rejection		T <sub>A</sub> = 25°C	90	100		í
CMRR	ratio	$(V-) - 0.1 V < V_{CM} < (V+) + 0.1 V$	$T_A = -40^{\circ}C$ to $125^{\circ}C$	90			dB
INPUT B	IAS CURRENT	-					
		$T_A = 25^{\circ}C$			±0.2	±10	
		$T_A = -40^{\circ}C$ to $85^{\circ}C$				±50	
I <sub>B</sub>	Input bias current	OPA322 and OPA322S, $T_A = -40^{\circ}$ C	C to 125°C			±800	pА
		OPA2322 and OPA2322S, $T_A = -40$	0°C to 125°C			±400	
		OPA4322 and OPA4322S, $T_A = -40$	0°C to 125°C			±400	
		T <sub>A</sub> = 25°C			±0.2	±10	
I <sub>OS</sub>	Input offset current	$T_A = -40^{\circ}C$ to $85^{\circ}C$				±50	pА
		$T_A = -40^{\circ}C$ to $125^{\circ}C$				±400	
NOISE		-					
	Input voltage noise	f = 0.1 Hz to 10 Hz			2.8		$\mu V_{PP}$
		f = 1 kHz			8.5		N// H
e <sub>n</sub>	Input voltage noise density	f = 10 kHz			7		nV/√Hz
i <sub>n</sub>	Input current noise density	f = 1 kHz			0.6		fA/√Hz
INPUT C	APACITANCE	-					
	Differential				5		pF
	Common-mode				4		pF
OPEN-LC	DOP GAIN	-					
		$0.1 \text{ V} < \text{V}_{\text{O}} < (\text{V+}) - 0.1 \text{ V}, \text{R}_{\text{L}} = 10$	kΩ	100	130		ī
A <sub>OL</sub>	Open-loop voltage gain	$0.1 \text{ V} < \text{V}_{\text{O}} < (\text{V+}) - 0.1 \text{ V}, \text{ R}_{\text{L}} = 10$	kΩ	94			dB
PM	Phase margin	$V_{\rm S} = 5 \text{ V}, C_{\rm L} = 50 \text{ pF}$			47		0
FREQUE	NCY RESPONSE	·					
GBP	Gain bandwidth product	$V_{S} = 5 V, C_{L} = 50 pF$ , unity gain			20		MHz
SR	Slew rate	$V_{S} = 5 V, C_{L} = 50 pF, G = +1$			10		V/µs
	O a tillia a tilaa a	$V_{\rm S}$ = 5 V, $C_{\rm L}$ = 50 pF, to 0.1%, 2-V	step, G = +1		0.25		_
t <sub>S</sub>	Settling time	$V_{\rm S}$ = 5 V, $C_{\rm L}$ = 50 pF, to 0.01%, 2-V	′ step, G = +1		0.32		μS
	Overload recovery time	$V_{\rm S}$ = 5 V, $C_{\rm L}$ = 50 pF, $V_{\rm IN}$ × G > $V_{\rm S}$			100		ns
TUD .:	Total harmonic distortion +	$V_{S} = 5 \text{ V},  \text{C}_{L} = 50 \text{ pF},  \text{V}_{O} = 4  \text{V}_{\text{PP}},  \text{C}$ $R_{L} = 10  \text{k}\Omega$	G = +1, f = 10 kHz,		0.0005%		
THD+N	noise <sup>(1)</sup>	$V_{\rm S} = 5 \text{ V}, \text{ C}_{\rm L} = 50 \text{ pF}, \text{ V}_{\rm O} = 2 \text{ V}_{\rm PP}, \text{ O}$ $R_{\rm L} = 600 \Omega$	G = +1, f = 10 kHz,		0.0011%		

(1) Third-order filter; bandwidth = 80 kHz at -3 dB



#### Electrical Characteristics (continued)

At V<sub>S</sub> = 1.8 V to 5.5 V, or ±0.9 V to ±2.75 V, T<sub>A</sub> = 25°C, R<sub>L</sub> = 10 k $\Omega$  connected to V<sub>S</sub>/2, V<sub>CM</sub> = V<sub>S</sub>/2, V<sub>OUT</sub> = V<sub>S</sub>/2, and SHDN  $x = V_s +$  (unless otherwise noted).

	PARAMETER	TEST CON	IDITIONS	MIN	TYP	MAX	UNIT
OUTPUT	Ī						
V	Voltage output (swing from	D 10.40	$T_A = 25^{\circ}C$		10	20	mV
Vo	both rails)	$R_L = 10 \ k\Omega$	$T_A = -40^{\circ}C$ to $125^{\circ}C$			30	mv
I <sub>SC</sub>	Short-circuit current	V <sub>S</sub> = 5.5 V			±65		mA
CL	Capacitive load drive			See Typic	al Characteris	stics	
Ro	Open-loop output resistance	I <sub>O</sub> = 0 mA, f = 1 MHz			90		Ω
POWER	SUPPLY	I				4	
Vs	Specified voltage range			1.8		5.5	V
		OPA322 and OPA322S.	$T_A = 25^{\circ}C$		1.6	1.9	
		$I_0 = 0 \text{ mA}, V_S = 5.5 \text{ V}$	$T_A = -40^{\circ}C$ to $125^{\circ}C$			2	
	Quiescent current per amplifier	OPA2322 and OPA2322S.	T <sub>A</sub> = 25°C		1.5	1.75	
lQ		$I_0 = 0 \text{ mA}, V_S = 5.5 \text{ V}$	$T_A = -40^{\circ}C$ to $125^{\circ}C$			1.85	mA
		OPA4322 and OPA4322S.	T <sub>A</sub> = 25°C		1.4	1.65	
		$I_0 = 0 \text{ mA}, V_S = 5.5 \text{ V}$	$T_A = -40^{\circ}C$ to $125^{\circ}C$			1.75	
	Power-on time	$V_{S+} = 0 V$ to 5 V, to 90% $I_Q$ leve	1		28		μS
SHUTDO	DWN <sup>(2)</sup>					1	
I <sub>QSD</sub>	Quiescent current (per amplifier)	$V_{S}$ = 1.8 V to 5.5 V, all amplifier	s disabled, $\overline{SHDN} = V_{S-}$		0.1	0.5	μA
VIH	High voltage (enabled)	V <sub>S</sub> = 1.8 V to 5.5 V, amplifier er	abled	(V+) – 0.1			V
VIL	Low voltage (disabled)	V <sub>S</sub> = 1.8 V to 5.5 V, amplifier dis	sabled			(V–) + 0.1	V
	Amplifier enable time (full shutdown) <sup>(3)</sup>	$V_{S}$ = 1.8 V to 5.5 V, full shutdow $V_{OUT}$ = 0.9 × $V_{S}/2^{(4)}$	vn; G = 1,		10		μs
t <sub>ON</sub>	Amplifier enable time (partial shutdown) <sup>(3)</sup>	$V_{S}$ = 1.8 V to 5.5 V, partial shute $V_{OUT}$ = 0.9 $\times$ V_{S}/2^{(4)}	down; G = 1,		6		μs
t <sub>OFF</sub>	Amplifier disable time <sup>(3)</sup>	$V_{\rm S}$ = 1.8 V to 5.5 V, G = 1, $V_{\rm OU}$	$r = 0.1 \times V_{S}/2$		3		μs
	SHDN pin input bias current	$V_{\rm S}$ = 1.8 V to 5.5 V, $V_{\rm IH}$ = 5 V			0.13		
	(per pin)	$V_{S} = 1.8 \text{ V to } 5.5 \text{ V}, V_{IL} = 0 \text{ V}$			0.04		μA

Ensured by design and characterization; not production tested. (2)

(3) Disable time (t<sub>OFF</sub>) and enable time (t<sub>ON</sub>) are defined as the time interval between the 50% point of the signal applied to the SHDN pin

and the point at which the output voltage reaches the 10% (disable) or 90% (enable) level. Full shutdown refers to the dual OPA2322S having both channels A and B disabled (SHDN\_A = SHDN\_B =  $V_{S-}$ ) and the quad OPA4322S having all channels A to D disabled (SHDN\_A/B = SHDN\_C/D =  $V_{S-}$ ). For partial shutdown, only one SHDN pin is exercised; (4) in this mode, the internal biasing and oscillator remain operational and the enable time is shorter.

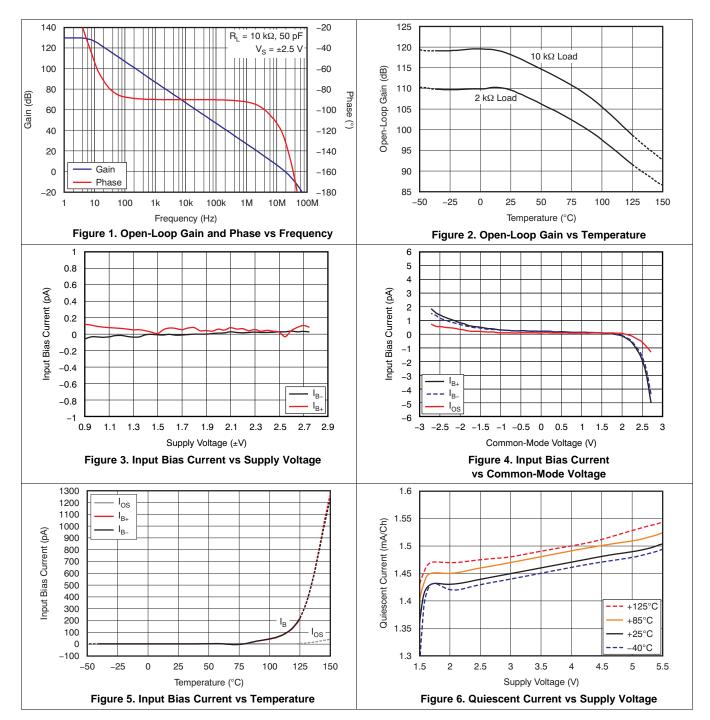


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### 6.8 Typical Characteristics

At  $T_A = 25^{\circ}$ C,  $V_{CM} = V_{OUT}$  = mid-supply, and  $R_L = 10 \text{ k}\Omega$  (unless otherwise noted).

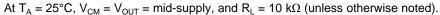


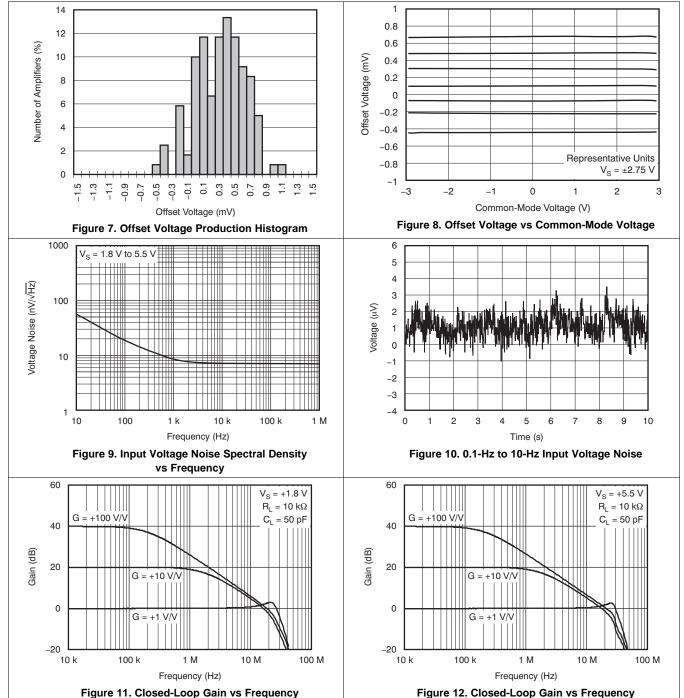
OPA322, OPA322S OPA2322, OPA2322S OPA4322, OPA4322S SBOS538F – JANUARY 2011 – REVISED DECEMBER 2016



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## **Typical Characteristics (continued)**





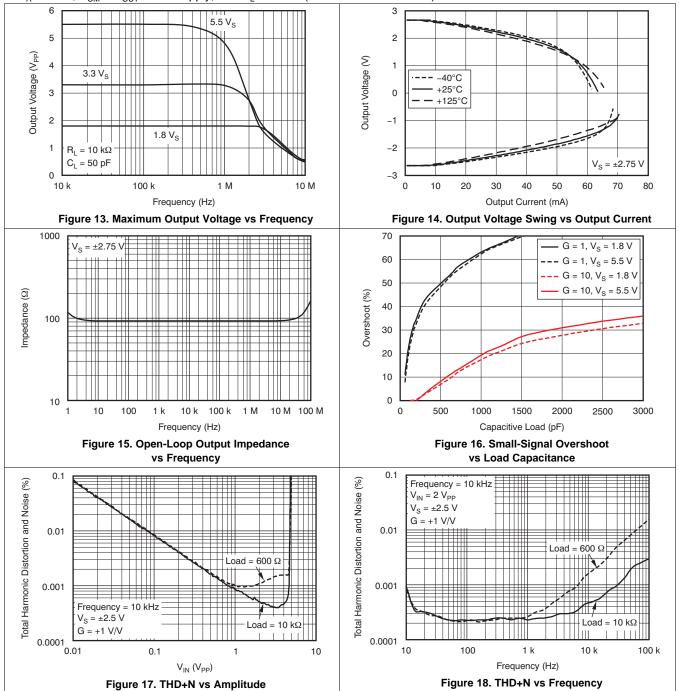


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### **Typical Characteristics (continued)**

At  $T_A = 25^{\circ}$ C,  $V_{CM} = V_{OUT}$  = mid-supply, and  $R_L = 10 \text{ k}\Omega$  (unless otherwise noted).



#### OPA322, OPA322S OPA2322, OPA2322S OPA4322, OPA4322S

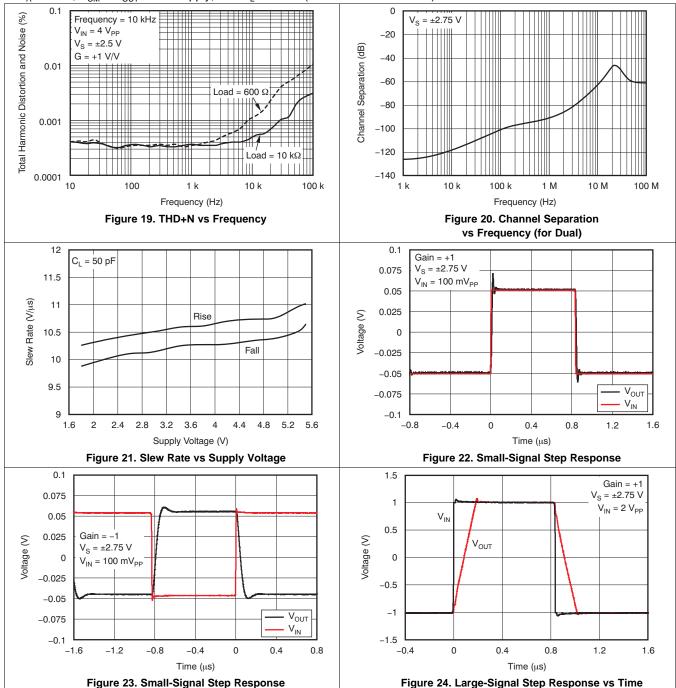
SBOS538F - JANUARY 2011 - REVISED DECEMBER 2016



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## **Typical Characteristics (continued)**

At  $T_A = 25^{\circ}$ C,  $V_{CM} = V_{OUT}$  = mid-supply, and  $R_L = 10 \text{ k}\Omega$  (unless otherwise noted).

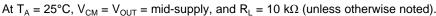


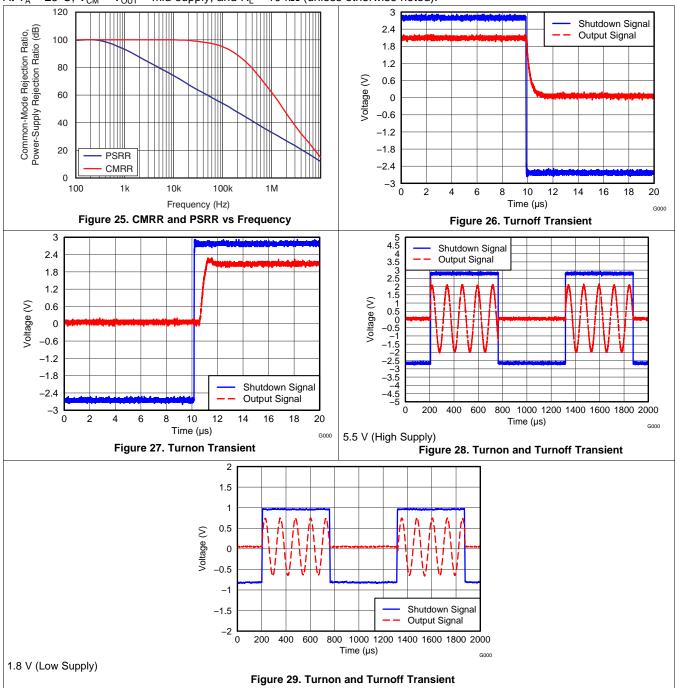


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## **Typical Characteristics (continued)**





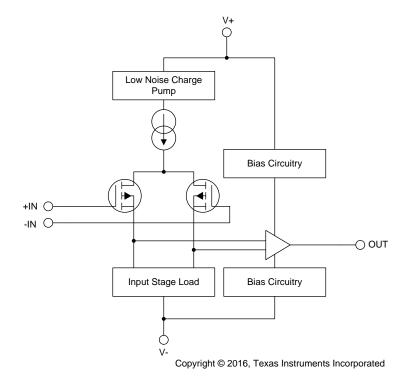


## 7 Detailed Description

#### 7.1 Overview

The OPA322 family of operational amplifiers (op amps) are high-speed, precision amplifiers perfectly suited to drive 12-, 14-, and 16-bit analog-to-digital converters. Low-output impedance with flat frequency characteristics and zero-crossover distortion circuitry enable high linearity over the full input common-mode range, achieving true rail-to-rail input from a 1.8-V to 5.5-V single supply.

### 7.2 Functional Block Diagram



### 7.3 Feature Description

### 7.3.1 Operating Voltage

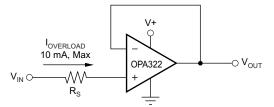
The OPA322 series op amps are unity-gain stable and can operate on a single-supply voltage (1.8 V to 5.5 V), or a split-supply voltage ( $\pm 0.9$  V to  $\pm 2.75$  V), making them highly versatile and easy to use. The power-supply pins must have local bypass ceramic capacitors (typically 0.001  $\mu$ F to 0.1  $\mu$ F). These amplifiers are fully specified from 1.8 V to 5.5 V and over the extended temperature range of  $-40^{\circ}$ C to 125°C. Parameters that can exhibit variance with regard to operating voltage or temperature are presented in the *Typical Characteristics*.

### 7.3.2 Input and ESD Protection

The OPA322 incorporates internal electrostatic discharge (ESD) protection circuits on all pins. In the case of input and output pins, this protection primarily consists of current-steering diodes connected between the input and power-supply pins. These ESD protection diodes also provide in-circuit input overdrive protection, as long as the current is limited to 10 mA as stated in the *Absolute Maximum Ratings*. Many input signals are inherently current-limited to less than 10 mA; therefore, a limiting resistor is not required. Figure 30 shows how a series input resistor ( $R_S$ ) may be added to the driven input to limit the input current. The added resistor contributes thermal noise at the amplifier input and the value must be kept to the minimum in noise-sensitive applications.



# Feature Description (continued)



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Figure 30. Input Current Protection

#### 7.3.3 Phase Reversal

The OPA322 op amps are designed to be immune to phase reversal when the input pins exceed the supply voltages, therefore providing further in-system stability and predictability. Figure 31 shows the input voltage exceeding the supply voltage without any phase reversal.

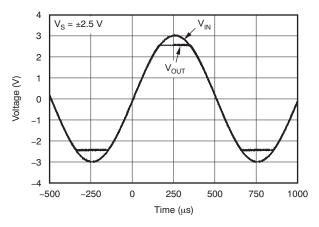
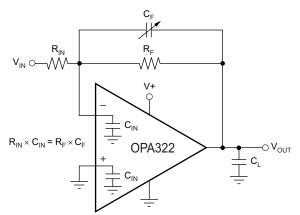


Figure 31. No Phase Reversal

#### 7.3.4 Feedback Capacitor Improves Response

For optimum settling time and stability with high-impedance feedback networks, it may be necessary to add a feedback capacitor across the feedback resistor,  $R_F$ , as shown in Figure 32. This capacitor compensates for the zero created by the feedback network impedance and the OPA322 input capacitance (and any parasitic layout capacitance). The effect becomes more significant with higher impedance networks.



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NOTE: Where C<sub>IN</sub> is equal to the OPA322 input capacitance (approximately 9 pF) plus any parasitic layout capacitance.

#### Figure 32. Feedback Capacitor Improves Dynamic Performance



(1)

#### Feature Description (continued)

For the circuit shown in Figure 32, the value of the variable feedback capacitor must be chosen so that the input resistance times the input capacitance of the OPA322 (typically 9 pF) plus the estimated parasitic layout capacitance equals the feedback capacitor times the feedback resistor with Equation 1.

 $R_{IN} \times C_{IN} = R_F \times C_F$ 

where

C<sub>IN</sub> is equal to the OPA322 input capacitance (sum of differential and common-mode) plus the layout capacitance

The capacitor value can be adjusted until optimum performance is obtained.

#### 7.3.5 EMI Susceptibility and Input Filtering

Operational amplifiers vary in susceptibility to electromagnetic interference (EMI). If conducted EMI enters the device, the DC offset observed at the amplifier output may shift from the nominal value while EMI is present. This shift is a result of signal rectification associated with the internal semiconductor junctions. While all operational amplifier pin functions can be affected by EMI, the input pins are likely to be the most susceptible. The OPA322 operational amplifier family incorporates an internal input low-pass filter that reduces the amplifier response to EMI. Both common-mode and differential mode filtering are provided by the input filter. The filter is designed for a cutoff frequency of approximately 580 MHz (–3 dB), with a roll-off of 20 dB per decade.

#### 7.3.6 Output Impedance

The open-loop output impedance of the OPA322 common-source output stage is approximately 90  $\Omega$ . When the op amp is connected with feedback, this value is reduced significantly by the loop gain. For each decade rise in the closed-loop gain, the loop gain is reduced by the same amount, which results in a tenfold increase in effective output impedance. While the OPA322 output impedance remains very flat over a wide frequency range, at higher frequencies the output impedance rises as the open-loop gain of the op amp drops. However, at these frequencies the output also becomes capacitive as a result of parasitic capacitance. This characteristic, in turn, prevents the output impedance from becoming too high, which can cause stability problems when driving large capacitive loads. As mentioned previously, the OPA322 has excellent capacitive load drive capability for an op amp with its bandwidth.

#### 7.3.7 Capacitive Load and Stability

The OPA322 is designed to be used in applications where driving a capacitive load is required. As with all op amps, there may be specific instances where the OPA322 can become unstable. The particular op amp circuit configuration, layout, gain, and output loading are some of the factors to consider when establishing whether an amplifier is stable in operation. An op amp in the unity-gain (+1-V/V) buffer configuration and driving a capacitive load exhibits a greater tendency to become unstable than an amplifier operated at a higher noise gain. The capacitive load, in conjunction with the op amp output resistance, creates a pole within the feedback loop that degrades the phase margin. The degradation of the phase margin increases as the capacitive loading increases. When operating in the unity-gain configuration, the OPA322 remains stable with a pure capacitive load up to approximately 1 nF.

The equivalent series resistance (ESR) of some very large capacitors ( $C_L > 1 \ \mu$ F) is sufficient to alter the phase characteristics in the feedback loop such that the amplifier remains stable. Increasing the amplifier closed-loop gain allows the amplifier to drive increasingly larger capacitance. This increased capability is evident when observing the overshoot response of the amplifier at higher voltage gains, as shown in Figure 33. One technique for increasing the capacitive load drive capability of the amplifier operating in unity gain is to insert a small resistor ( $R_S$ ), typically 10  $\Omega$  to 20  $\Omega$ , in series with the output, as shown in Figure 34.

This resistor significantly reduces the overshoot and ringing associated with large capacitive loads. A possible problem with this technique is that a voltage divider is created with the added series resistor and any resistor connected in parallel with the capacitive load. The voltage divider introduces a gain error at the output that reduces the output swing. The error contributed by the voltage divider, however, may be insignificant. For instance, with a load resistance,  $R_L = 10 \ k\Omega$  and  $R_S = 20 \ \Omega$ , the gain error is only about 0.2%. However, when  $R_L$  is decreased to 600  $\Omega$ , which the OPA322 is able to drive, the error increases to 7.5%.

18 Submit Documentation Feedback Copyright © 2011–2016, Texas Instruments Incorporated Product Folder Links: OPA322 OPA322S OPA2322 OPA2322 OPA4322 OPA4322S



#### Feature Description (continued)

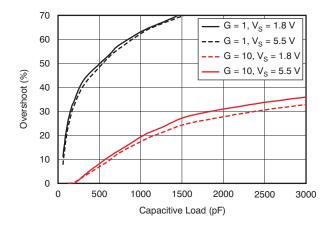


Figure 33. Small-Signal Overshoot vs Capacitive Load (100-mV<sub>PP</sub> Output Step)

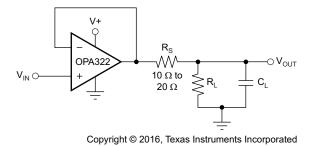
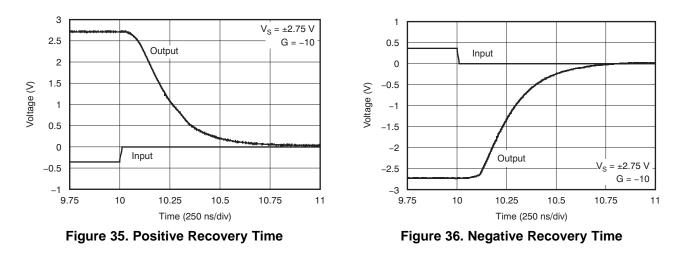


Figure 34. Improving Capacitive Load Drive

#### 7.3.8 Overload Recovery Time

Overload recovery time is the time required for the output of the amplifier to come out of saturation and recover to the linear region. Overload recovery is particularly important in applications where small signals must be amplified in the presence of large transients. Figure 35 and Figure 36 show the positive and negative overload recovery times of the OPA322, respectively. In both cases, the time elapsed before the OPA322 comes out of saturation is less than 100 ns. In addition, the symmetry between the positive and negative recovery times allows excellent signal rectification without distortion of the output signal.



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Product Folder Links: OPA322 OPA322S OPA2322 OPA2322S OPA4322 OPA4322S



#### Feature Description (continued)

#### 7.3.9 Shutdown Function

The SHDN (enable) pin function of the OPAx322S is referenced to the negative supply voltage of the operational amplifier. A logic level high enables the op amp. A valid logic high is defined as voltage [(V+) - 0.1 V], up to (V+), applied to the SHDN pin. A valid logic low is defined as [(V-) + 0.1 V], down to (V-), applied to the enable pin. The maximum allowed voltage applied to SHDN is 5.5 V with respect to the negative supply, independent of the positive supply voltage. This pin must either be connected to a valid high or a low voltage or driven, and not left as an open circuit.

The logic input is a high-impedance CMOS input. Dual op amp versions are independently controlled and quad op amp versions are controlled in pairs with logic inputs. For battery-operated applications, this feature may be used to greatly reduce the average current and extend battery life. The enable time is 10  $\mu$ s for full shutdown of all channels; disable time is 3  $\mu$ s. When disabled, the output assumes a high-impedance state. This architecture allows the OPAx322S to be operated as a *gated* amplifier (or to have the device output multiplexed onto a common analog output bus). Shutdown time (t<sub>OFF</sub>) depends on loading conditions and increases with increased load resistance. To ensure shutdown (disable) within a specific shutdown time, the specified 10-k $\Omega$  load to mid-supply (V<sub>S</sub> / 2) is required. If using the OPAx322S without a load, the resulting turnoff time is significantly increased.

#### 7.4 Device Functional Modes

The OPA322 family of operational amplifiers are operational when power-supply voltages between 1.8 V to 5.5 V are applied. Devices with an *S* suffix have a shutdown capability. For a detailed description of the shutdown function, refer to *Shutdown Function*.



## 8 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 8.1 Application Information

The OPA322 family offers outstanding DC and AC performance. These devices operate up to a 5.5-V power supply and offer ultra-low input bias current and 20-MHz bandwidth. These features make the OPA322 family a robust operational amplifier for both battery-powered and industrial applications.

#### 8.1.1 Active Filter

The OPA322 is well-suited for active filter applications that require a wide bandwidth, fast slew rate, low-noise, single-supply operational amplifier. Figure 37 shows a 500-kHz, second-order, low-pass filter using the multiple-feedback (MFB) topology. The components have been selected to provide a maximally-flat Butterworth response. Beyond the cutoff frequency, roll-off is –40 dB/dec. The Butterworth response is ideal for applications that require predictable gain characteristics, such as the anti-aliasing filter used in front of an ADC.

One point to observe when considering the MFB filter is that the output is inverted, relative to the input. If this inversion is not required, or not desired, a noninverting output can be achieved through one of these options:

- 1. adding an inverting amplifier;
- 2. adding an additional second-order MFB stage; or
- 3. using a noninverting filter topology, such as the Sallen-Key (shown in Figure 38).

MFB, Sallen-Key, low-pass, and high-pass filter synthesis is quickly accomplished using TI's FilterPro<sup>™</sup> program. This software is available as a free download at www.ti.com.

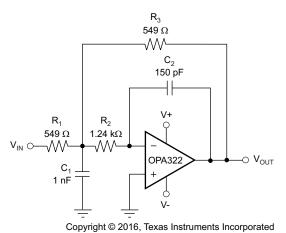
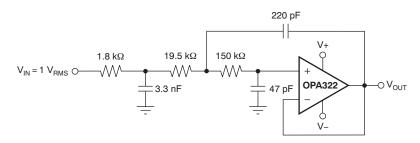


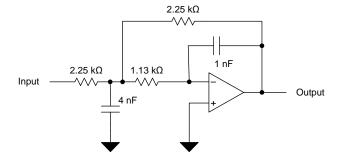
Figure 37. Second-Order, Butterworth, 500-kHz Low-Pass Filter







## 8.2 Typical Application



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#### Figure 39. Second-Order, Low-Pass Filter Schematic

#### 8.2.1 Design Requirements

- Gain = 1 V/V
- Low-pass cutoff frequency = 50 kHz
- –40-db/dec filter response
- Maintain less than 3-dB gain peaking in the gain versus frequency response

#### 8.2.2 Detailed Design Procedure

The infinite-gain multiple-feedback circuit for a low-pass network function is shown in. Use Equation 2 to calculate the voltage transfer function.

$$\frac{\text{Output}}{\text{Input}}(s) = \frac{-1/R_1R_3C_2C_5}{s^2 + (s/C_2)(1/R_1 + 1/R_3 + 1/R_4) + 1/R_3R_4C_2C_5}$$
(2)

This circuit produces a signal inversion. For this circuit, the gain at DC and the lowpass cutoff frequency are calculated by Equation 3.

Gain = 
$$\frac{R_4}{R_1}$$
  
f<sub>C</sub> =  $\frac{1}{2\pi} \sqrt{(1/R_3 R_4 C_2 C_5)}$  (3)

Software tools are readily available to simplify filter design. WEBENCH<sup>®</sup> Filter Designer is a simple, powerful, and easy-to-use active filter design program. The WEBENCH<sup>®</sup> Filter Designer lets you create optimized filter designs using a selection of TI operational amplifiers and passive components from TI's vendor partners.

Available as a web-based tool from the WEBENCH Design Center, WEBENCH Filter Designer allows you to design, optimize, and simulate complete multistage active filter solutions within minutes.



#### **Typical Application (continued)**

#### 8.2.3 Application Curve

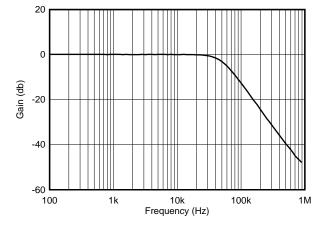


Figure 40. OPA322 Second-Order, 50-kHz, Low-Pass Filter

## 9 Power Supply Recommendations

The OPA322 family is specified for operation from 1.8 V to 5.5 V ( $\pm$ 0.9 V to  $\pm$ 2.75 V); many specifications apply from  $-40^{\circ}$ C to 125°C. Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the *Typical Characteristics*.

#### CAUTION

Supply voltages larger than 6 V can permanently damage the device; see the *Absolute Maximum Ratings*.

Place 0.1-µF bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or highimpedance power supplies. For more detailed information on bypass capacitor placement, refer to the *Layout*.



## 10 Layout

#### 10.1 Layout Guidelines

The OPA322 is a wideband amplifier. To realize the full operational performance of the device, follow good highfrequency printed-circuit board (PCB) layout practices. The bypass capacitors must be connected between each supply pin and ground as close to the device as possible. The bypass capacitor traces must be designed for minimum inductance.

#### 10.1.1 Leadless DFN Package

The OPA2322 uses the DFN style package (also known as SON), which is a QFN with contacts on only two sides of the package bottom. This leadless package maximizes PCB space and offers enhanced thermal and electrical characteristics through an exposed pad. One of the primary advantages of the DFN package is its low height (0.8 mm).

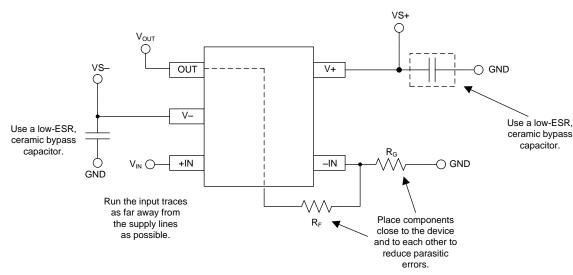
DFN packages are physically small, and have a smaller routing area. Additionally, they offer improved thermal performance, reduced electrical parasitics, and a pinout scheme that is consistent with other commonly-used packages (such as SOIC and VSSOP). The absence of external leads also eliminates bent-lead issues.

The DFN package can easily be mounted using standard PCB assembly techniques. See the application reports, *QFN/SON PCB Attachment* and *Quad Flatpack No-Lead Logic Packages*. The dimension of the exposed thermal die pad is 2 mm × 1.2 mm and is centered.

NOTE

The exposed leadframe die pad on the bottom of the DFN package must be connected to the most negative potential (V–).





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Figure 41. Layout Example

Product Folder Links: OPA322 OPA322S OPA2322 OPA2322S OPA4322 OPA4322S



## 11 Device and Documentation Support

## 11.1 Device Support

#### 11.1.1 Third-Party Products Disclaimer

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#### 11.1.2 Development Support

#### 11.1.2.1 TINA-TI<sup>™</sup> (Free Software Download)

TINA<sup>™</sup> is a simple, powerful, and easy-to-use circuit simulation program based on a SPICE engine. TINA-TI<sup>™</sup> is a free, fully-functional version of the TINA software, preloaded with a library of macro models in addition to a range of both passive and active models. TINA-TI provides all the conventional DC, transient, and frequency domain analysis of SPICE, as well as additional design capabilities.

Available as a free download from the Analog eLab Design Center, TINA-TI offers extensive post-processing capability that allows users to format results in a variety of ways. Virtual instruments offer the ability to select input waveforms and probe circuit nodes, voltages, and waveforms, creating a dynamic quick-start tool.

#### NOTE

These files require that either the TINA software (from DesignSoft<sup>™</sup>) or TINA-TI software be installed. Download the free TINA-TI software from the TINA-TI folder.

#### 11.1.2.2 DIP Adapter EVM

The DIP Adapter EVM tool provides an easy, low-cost way to prototype small surface mount ICs. The evaluation tool these TI packages: D or U (SOIC-8), PW (TSSOP-8), DGK (VSSOP-8), DBV (SOT23-6, SOT23-5 and SOT23-3), DCK (SC70-6 and SC70-5), and DRL (SOT563-6). The DIP Adapter EVM may also be used with terminal strips or may be wired directly to existing circuits.

#### 11.1.2.3 Universal Operational Amplifier EVM

The Universal Op Amp EVM is a series of general-purpose, blank circuit boards that simplify prototyping circuits for a variety of IC package types. The evaluation module board design allows many different circuits to be constructed easily and quickly. Five models are offered, with each model intended for a specific package type. PDIP, SOIC, VSSOP, TSSOP and SOT-23 packages are all supported.

#### NOTE

These boards are unpopulated, so users must provide their own ICs. TI recommends requesting several op amp device samples when ordering the Universal Op Amp EVM.

### 11.1.2.4 TI Precision Designs

TI Precision Designs are analog solutions created by TI's precision analog applications experts and offer the theory of operation, component selection, simulation, complete PCB schematic and layout, bill of materials, and measured performance of many useful circuits. TI Precision Designs are available online at http://www.ti.com/ww/en/analog/precision-designs/.

## 11.1.2.5 WEBENCH<sup>®</sup> Filter Designer

WEBENCH® Filter Designer is a simple, powerful, and easy-to-use active filter design program. The WEBENCH Filter Designer lets you create optimized filter designs using a selection of TI operational amplifiers and passive components from TI's vendor partners.

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Product Folder Links: OPA322 OPA322S OPA2322 OPA2322S OPA4322 OPA4322S



### **Device Support (continued)**

Available as a web-based tool from the WEBENCH® Design Center, WEBENCH® Filter Designer allows you to design, optimize, and simulate complete multistage active filter solutions within minutes.

### **11.2 Documentation Support**

#### 11.2.1 Related Documentation

The following documents are relevant to using the OPA322x, and recommended for reference. All are available for download at www.ti.com unless otherwise noted.

- QFN/SON PCB Attachment (SLUA271)
- Quad Flatpack No-Lead Logic Packages (SCBA017)
- OPA322, OPA2322, OPA4322 EMIR Immunity Performance (SBOT005)
- FilterPro<sup>™</sup> User's Guide (SBFA001)
- AFE for Transient Recorder and Digital Fault Recorder Using High-Speed ADCs and Differential Amplifiers (TIDUAT7)
- Reference Design for Interfacing Current Output Hall Sensors and CTs With Differential ADCs/MCUs (TIDUA57)
- Single-Ended Signal Conditioning Circuit for Current and Voltage Measurement Using Fluxgate Sensors (TIDU583)
- Differential Signal Conditioning Circuit for Current and Voltage Measurement Using Fluxgate Sensors (TIDU569)

#### 11.3 Related Links

Table 1 lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

PARTS	PARTS PRODUCT FOLDER		TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
OPA322	Click here	Click here	Click here	Click here	Click here
OPA322S	Click here	Click here	Click here	Click here	Click here
OPA2322	Click here	Click here	Click here	Click here	Click here
OPA2322S	Click here	Click here	Click here	Click here	Click here
OPA4322	Click here	Click here	Click here	Click here	Click here
OPA4322S	Click here	Click here	Click here	Click here	Click here

#### Table 1. Related Links

### 11.4 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 11.5 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E<sup>™</sup> Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support TI's Design Support** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

26 Submit Documentation Feedback



### 11.6 Trademarks

FilterPro, TINA-TI, E2E are trademarks of Texas Instruments. WEBENCH is a registered trademark of Texas Instruments. TINA, DesignSoft are trademarks of DesignSoft, Inc. All other trademarks are the property of their respective owners.

#### 11.7 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 11.8 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



# PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	<b>RoHS</b> (3)	Lead finish/ Ball material	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
OPA2322AID	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2322A
OPA2322AID.A	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2322A
OPA2322AIDGKR	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	Call TI   Nipdauag   Nipdau   Nipdau	Level-2-260C-1 YEAR	-40 to 125	OOZI
OPA2322AIDGKR.A	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OOZI
OPA2322AIDGKRG4	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OOZI
OPA2322AIDGKRG4.A	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OOZI
OPA2322AIDGKT	Active	Production	VSSOP (DGK)   8	250   SMALL T&R	Yes	Call TI   Nipdauag   Nipdau   Nipdau	Level-2-260C-1 YEAR	-40 to 125	OOZI
OPA2322AIDGKT.A	Active	Production	VSSOP (DGK)   8	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OOZI
OPA2322AIDR	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2322A
OPA2322AIDR.A	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2322A
OPA2322AIDRG4	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2322A
OPA2322AIDRG4.A	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2322A
OPA2322AIDRGR	Active	Production	SON (DRG)   8	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPCI
OPA2322AIDRGR.A	Active	Production	SON (DRG)   8	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPCI
OPA2322AIDRGRG4	Active	Production	SON (DRG)   8	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPCI
OPA2322AIDRGRG4.A	Active	Production	SON (DRG)   8	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPCI
OPA2322AIDRGT	Active	Production	SON (DRG)   8	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPCI
OPA2322AIDRGT.A	Active	Production	SON (DRG)   8	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPCI
OPA2322SAIDGSR	Active	Production	VSSOP (DGS)   10	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPBI
OPA2322SAIDGSR.A	Active	Production	VSSOP (DGS)   10	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPBI
OPA2322SAIDGST	Active	Production	VSSOP (DGS)   10	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPBI
OPA2322SAIDGST.A	Active	Production	VSSOP (DGS)   10	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPBI
OPA2322SAIDGSTG4	Active	Production	VSSOP (DGS)   10	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPBI
OPA2322SAIDGSTG4.A	Active	Production	VSSOP (DGS)   10	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPBI
OPA322AIDBVR	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU   SN   NIPDA	J Level-2-260C-1 YEAR	-40 to 125	RAD
OPA322AIDBVR.A	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAD
OPA322AIDBVR.B	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	-	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAD
OPA322AIDBVRG4	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAD



24-Jul-2025

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	<b>RoHS</b> (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking
	(1)	(2)			(3)	(4)	(5)		(0)
OPA322AIDBVRG4.A	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAD
OPA322AIDBVT	Active	Production	SOT-23 (DBV)   5	250   SMALL T&R	Yes	NIPDAU   NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAD
OPA322AIDBVT.A	Active	Production	SOT-23 (DBV)   5	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAD
OPA322AIDBVT.B	Active	Production	SOT-23 (DBV)   5	250   SMALL T&R	-	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAD
OPA322SAIDBVR	Active	Production	SOT-23 (DBV)   6	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAF
OPA322SAIDBVR.A	Active	Production	SOT-23 (DBV)   6	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAF
OPA322SAIDBVRG4	Active	Production	SOT-23 (DBV)   6	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAF
OPA322SAIDBVRG4.A	Active	Production	SOT-23 (DBV)   6	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAF
OPA322SAIDBVT	Active	Production	SOT-23 (DBV)   6	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAF
OPA322SAIDBVT.A	Active	Production	SOT-23 (DBV)   6	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAF
OPA4322AIPW	Active	Production	TSSOP (PW)   14	90   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O4322A
OPA4322AIPW.A	Active	Production	TSSOP (PW)   14	90   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O4322A
OPA4322AIPWR	Active	Production	TSSOP (PW)   14	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O4322A
OPA4322AIPWR.A	Active	Production	TSSOP (PW)   14	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O4322A
OPA4322SAIPW	Active	Production	TSSOP (PW)   16	90   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O4322SA
OPA4322SAIPW.A	Active	Production	TSSOP (PW)   16	90   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O4322SA
OPA4322SAIPWR	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O4322SA
OPA4322SAIPWR.A	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O4322SA

<sup>(1)</sup> **Status:** For more details on status, see our product life cycle.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.



<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF OPA2322, OPA322, OPA4322 :

• Automotive : OPA2322-Q1, OPA322-Q1, OPA4322-Q1

NOTE: Qualified Version Definitions:

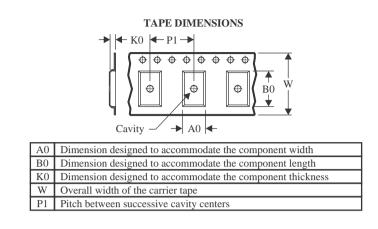
• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TEXAS

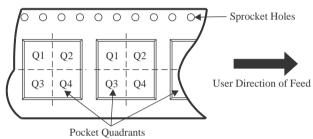
NSTRUMENTS

## TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package	Package	Pins	SPQ	Reel	Reel	A0	B0	K0	P1	W	Pin1
	Туре	Drawing			Diameter	Width	(mm)	(mm)	(mm)	(mm)	(mm)	Quadrant
					(mm)	W1 (mm)						
OPA2322AIDGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA2322AIDGKRG4	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA2322AIDGKT	VSSOP	DGK	8	250	180.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA2322AIDGKT	VSSOP	DGK	8	250	180.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA2322AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
OPA2322AIDRG4	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
OPA2322AIDRGR	SON	DRG	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
OPA2322AIDRGRG4	SON	DRG	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
OPA2322AIDRGT	SON	DRG	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
OPA2322SAIDGSR	VSSOP	DGS	10	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA2322SAIDGST	VSSOP	DGS	10	250	180.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA2322SAIDGSTG4	VSSOP	DGS	10	250	180.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA322AIDBVR	SOT-23	DBV	5	3000	179.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
OPA322AIDBVR	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
OPA322AIDBVRG4	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
OPA322AIDBVT	SOT-23	DBV	5	250	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3

# PACKAGE MATERIALS INFORMATION



www.ti.com

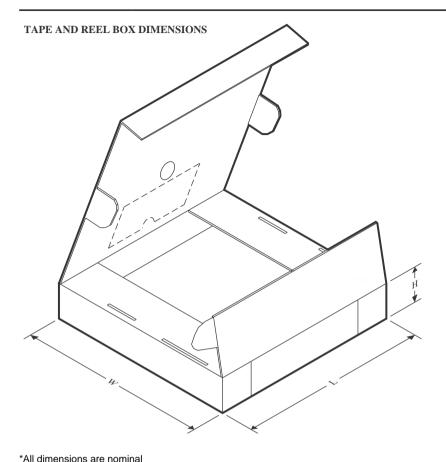
3-Aug-2025

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA322SAIDBVRG4	SOT-23	DBV	6	3000	180.0	8.4	3.15	3.1	1.55	4.0	8.0	Q3
OPA322SAIDBVT	SOT-23	DBV	6	250	180.0	8.4	3.15	3.1	1.55	4.0	8.0	Q3
OPA4322AIPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
OPA4322SAIPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



# PACKAGE MATERIALS INFORMATION

3-Aug-2025



Device	Package Type	Package Drawing	kage Drawing Pins S		Length (mm)	Width (mm)	Height (mm)
OPA2322AIDGKR	VSSOP	DGK	8	2500	353.0	353.0	32.0
OPA2322AIDGKRG4	VSSOP	DGK	8	2500	353.0	353.0	32.0
OPA2322AIDGKT	VSSOP	DGK	8	250	353.0	353.0	32.0
OPA2322AIDGKT	VSSOP	DGK	8	250	213.0	191.0	35.0
OPA2322AIDR	SOIC	D	8	2500	353.0	353.0	32.0
OPA2322AIDRG4	SOIC	D	8	2500	353.0	353.0	32.0
OPA2322AIDRGR	SON	DRG	8	3000	353.0	353.0	32.0
OPA2322AIDRGRG4	SON	DRG	8	3000	353.0	353.0	32.0
OPA2322AIDRGT	SON	DRG	8	250	213.0	191.0	35.0
OPA2322SAIDGSR	VSSOP	DGS	10	2500	353.0	353.0	32.0
OPA2322SAIDGST	VSSOP	DGS	10	250	213.0	191.0	35.0
OPA2322SAIDGSTG4	VSSOP	DGS	10	250	213.0	191.0	35.0
OPA322AIDBVR	SOT-23	DBV	5	3000	213.0	191.0	35.0
OPA322AIDBVR	SOT-23	DBV	5	3000	208.0	191.0	35.0
OPA322AIDBVRG4	SOT-23	DBV	5	3000	210.0	185.0	35.0
OPA322AIDBVT	SOT-23	DBV	5	250	210.0	185.0	35.0
OPA322SAIDBVRG4	SOT-23	DBV	6	3000	213.0	191.0	35.0
OPA322SAIDBVT	SOT-23	DBV	6	250	213.0	191.0	35.0



3-Aug-2025

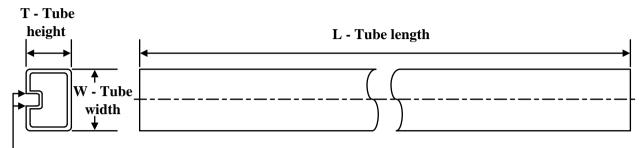
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA4322AIPWR	TSSOP	PW	14	2000	353.0	353.0	32.0
OPA4322SAIPWR	TSSOP	PW	16	2000	353.0	353.0	32.0

## TEXAS INSTRUMENTS

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3-Aug-2025

## TUBE



# - B - Alignment groove width

#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
OPA2322AID	D	SOIC	8	75	506.6	8	3940	4.32
OPA2322AID.A	D	SOIC	8	75	506.6	8	3940	4.32
OPA4322AIPW	PW	TSSOP	14	90	530	10.2	3600	3.5
OPA4322AIPW.A	PW	TSSOP	14	90	530	10.2	3600	3.5
OPA4322SAIPW	PW	TSSOP	16	90	530	10.2	3600	3.5
OPA4322SAIPW.A	PW	TSSOP	16	90	530	10.2	3600	3.5

# **DBV0005A**



# **PACKAGE OUTLINE**

# SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
   This drawing is subject to change without notice.
   Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



#### DBV0005A

### **EXAMPLE BOARD LAYOUT**

#### SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.



#### DBV0005A

### **EXAMPLE STENCIL DESIGN**

#### SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



### **DGK0008A**



#### **PACKAGE OUTLINE**

#### VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



NOTES:

PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.



#### DGK0008A

### **EXAMPLE BOARD LAYOUT**

#### <sup>™</sup> VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown
- on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.



#### DGK0008A

### **EXAMPLE STENCIL DESIGN**

# <sup>™</sup> VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



### DRG 8

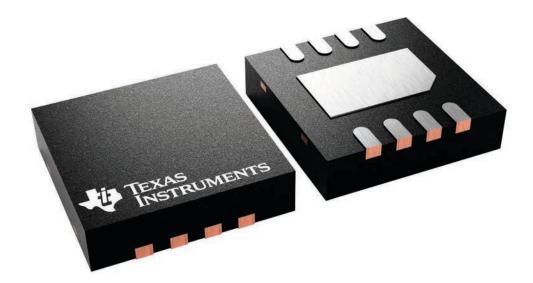
3 x 3, 0.5 mm pitch

### **GENERIC PACKAGE VIEW**

#### WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





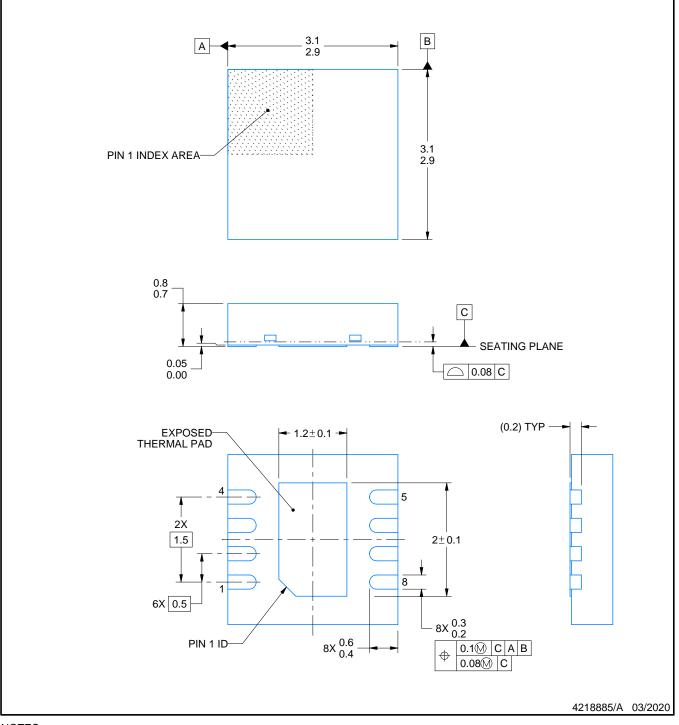
### **DRG0008A**



#### **PACKAGE OUTLINE**

#### WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
   This drawing is subject to change without notice.
   The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

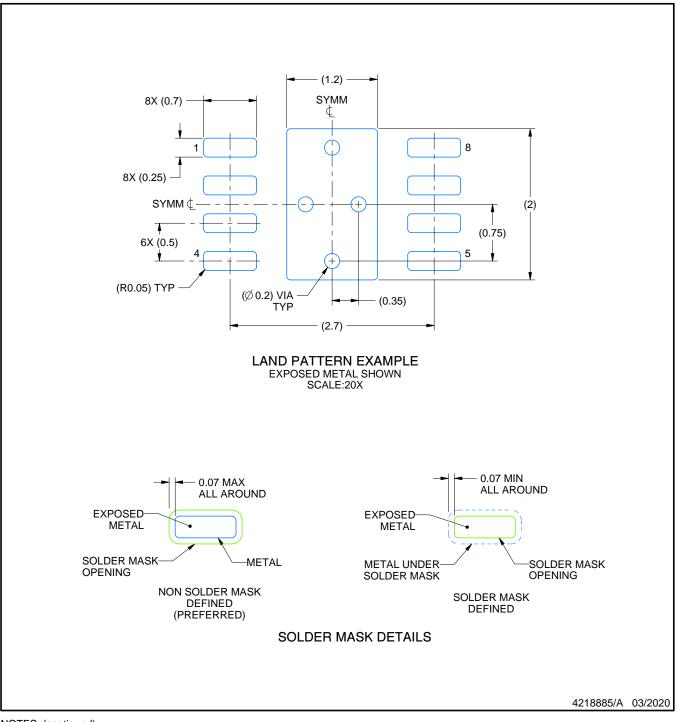


### DRG0008A

### **EXAMPLE BOARD LAYOUT**

#### WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

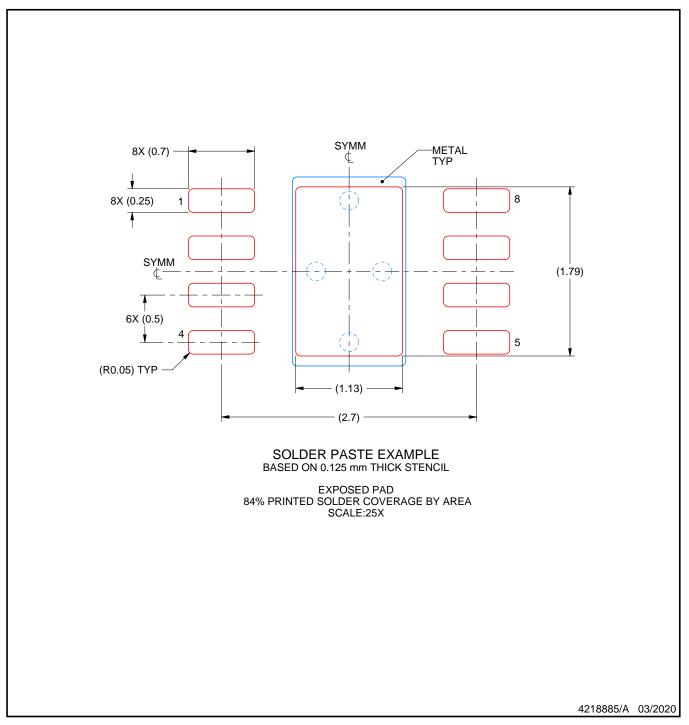


#### DRG0008A

### **EXAMPLE STENCIL DESIGN**

#### WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



## **DGS0010A**



#### **PACKAGE OUTLINE**

#### VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187, variation BA.

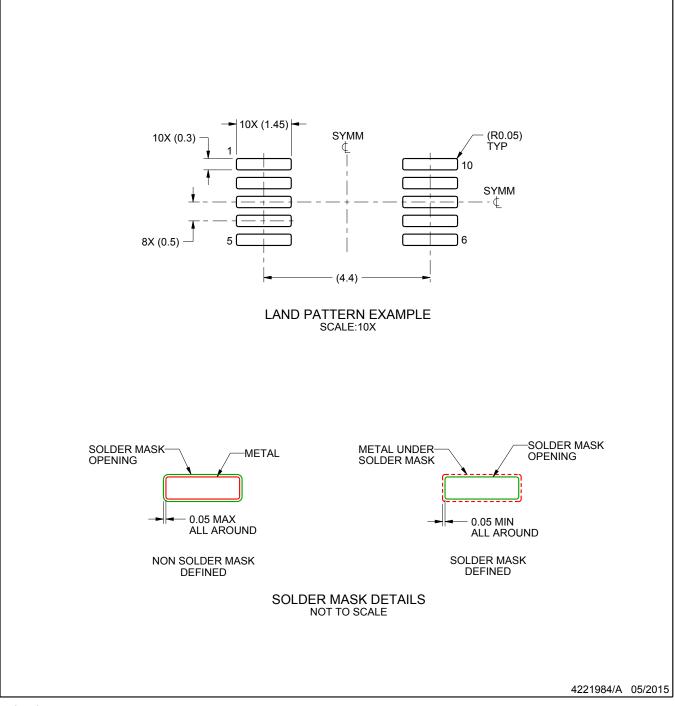


### DGS0010A

### **EXAMPLE BOARD LAYOUT**

#### VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.



### DGS0010A

### **EXAMPLE STENCIL DESIGN**

#### VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)



<sup>8.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

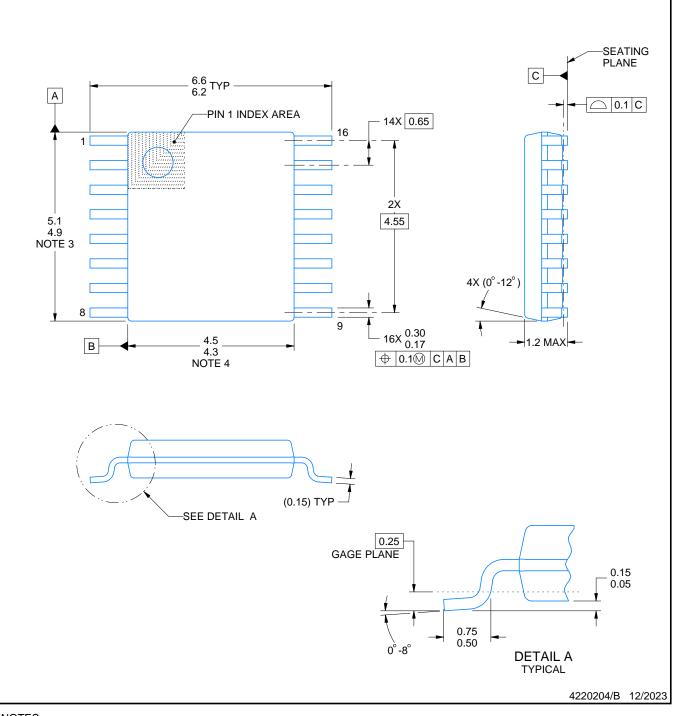
### **PW0016A**



#### **PACKAGE OUTLINE**

#### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.

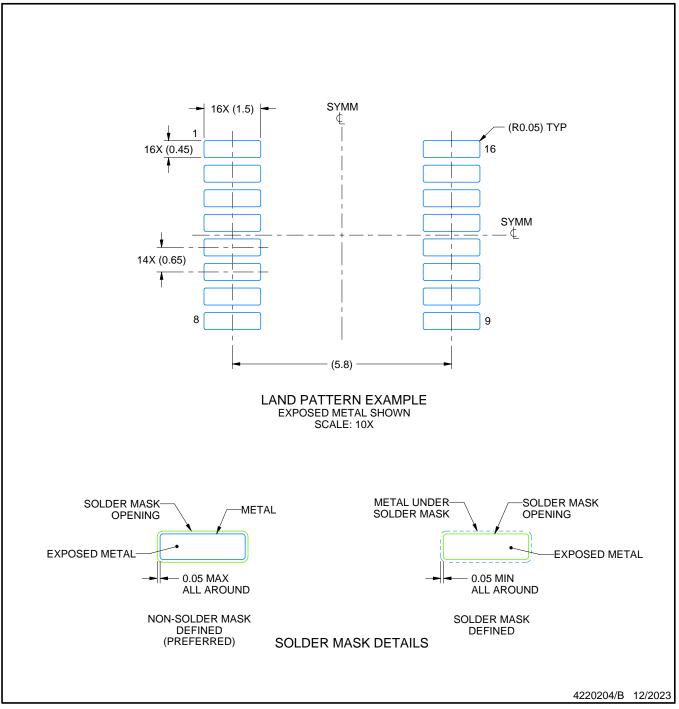


#### PW0016A

### **EXAMPLE BOARD LAYOUT**

#### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

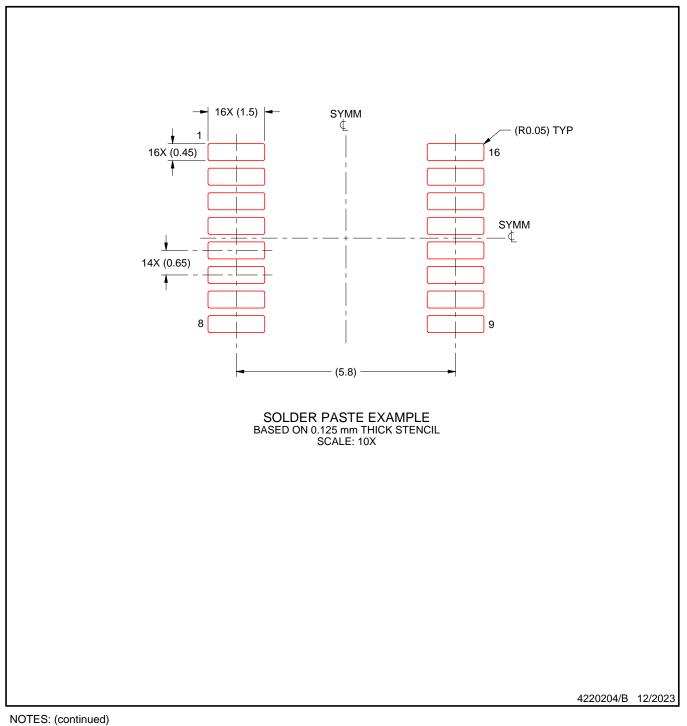


#### PW0016A

### **EXAMPLE STENCIL DESIGN**

#### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE





<sup>8.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

<sup>9.</sup> Board assembly site may have different recommendations for stencil design.

### D0008A



#### **PACKAGE OUTLINE**

#### SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.

- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



#### D0008A

### **EXAMPLE BOARD LAYOUT**

#### SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.



#### D0008A

### **EXAMPLE STENCIL DESIGN**

#### SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



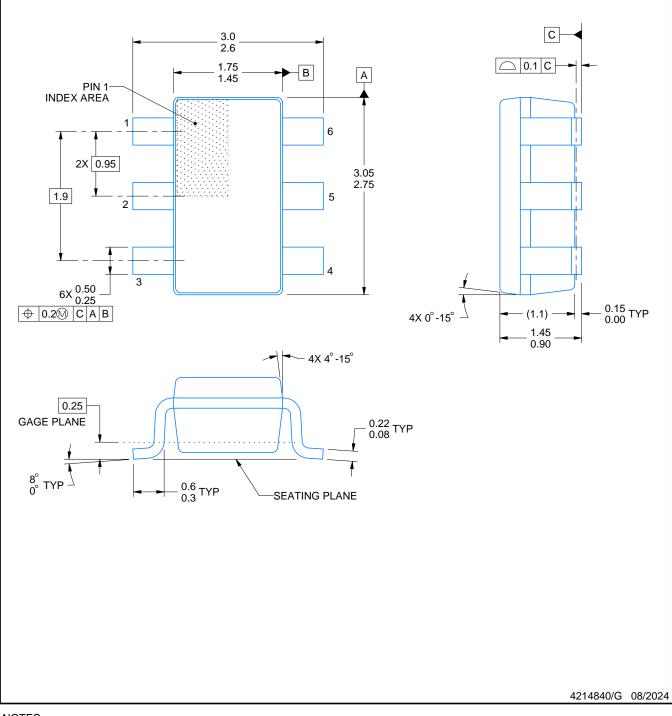
### **DBV0006A**



#### **PACKAGE OUTLINE**

#### SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.2. This drawing is subject to change without notice.3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.25 per side.

- 4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- 5. Refernce JEDEC MO-178.

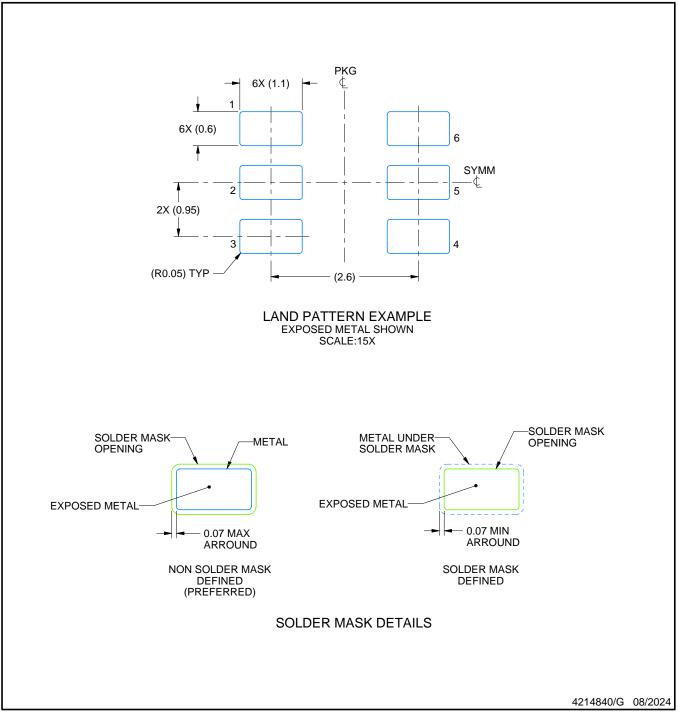


#### **DBV0006A**

### **EXAMPLE BOARD LAYOUT**

#### SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

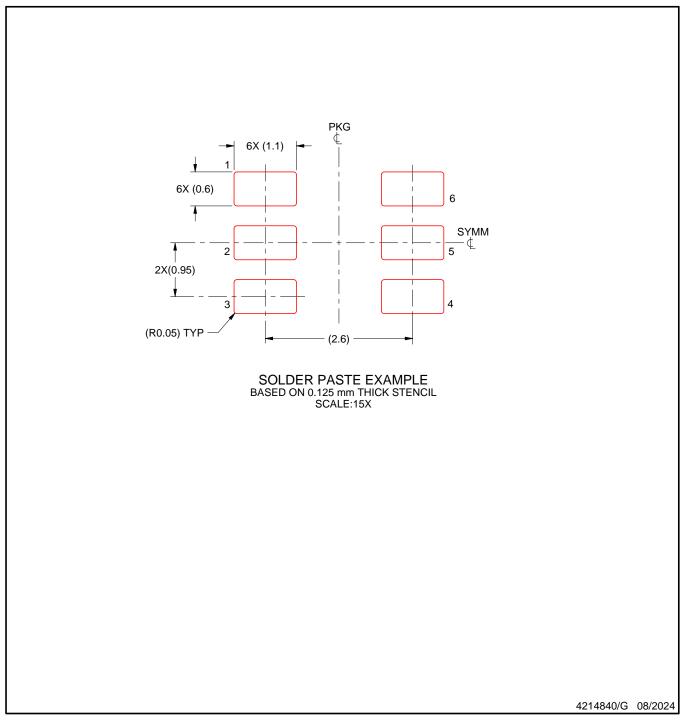


#### **DBV0006A**

### **EXAMPLE STENCIL DESIGN**

#### SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



### **PW0014A**



#### **PACKAGE OUTLINE**

#### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



#### PW0014A

### **EXAMPLE BOARD LAYOUT**

#### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.



#### PW0014A

### **EXAMPLE STENCIL DESIGN**

#### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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